

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/824,991 SHIBUYA ET AL.	
		Examiner	Art Unit	Page 1 of 1 Trang U. Tran 2614

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,333,627 B1	12-2001	Nishikawa	348/189
	B	US-6,014,168	01-2000	Webb et al.	348/190
	C	US-6,020,919	02-2000	Fujii et al.	348/190
	D	US-6,462,777 B1	10-2002	Hamaguri	348/188
	E	US-4,593,309	06-1986	Uno et al.	348/191
	F	US-5,896,170	04-1999	Webb et al.	348/190
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.